

INFORMATION DISCLOSURE STATEMENT BY APPLICANT Form PTO-1449	ATTY. DOCKET NO. 11113/9	SERIAL NO. To be assigned
	APPLICANT(S) WANG et al.	PTO 10/03556 11/07/01
	FILING DATE Herewith	

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS/ SUBCLASS	FILING DATE
CB	4,331,697	May 25, 1982	Kudo et al.	427/2.11	—
	4,377,010	March 22, 1983	Fydelor et al.	3/1.4	—
	4,442,133	April 10, 1984	Greco et al.	427/2.25	—
	4,589,964	May 20, 1986	Mayhan et al.	522/85	—
	4,743,258	May 10, 1988	Ikada et al.	623/1.49	—
	4,978,481	December 18, 1990	Janssen et al.	264/1.32	—
	5,002,582	March 26, 1991	Guire et al.	427/2.24	—
	5,069,899	December 3, 1991	Whitbourne et al.	424/56	—
	5,211,993	May 18, 1993	Kolesinski	427/488	—
	5,447,799	September 5, 1995	Loh et al.	428/448	—
	5,453,467	September 26, 1995	Bamford et al.	525/287	—
	5,525,348	June 11, 1996	Whitbourne et al.	424/423	—
	5,663,237	September 2, 1997	Lee et al.	525/285	—
	5,741,551	April 21, 1998	Guire et al.	427/407.1	—
	5,782,908	July 21, 1998	Cahalan et al.	623/1.13	—
CB	6,013,855	January 11, 2000	McPherson et al.	623/23,76	—
CB	6,096,369	August 1, 2000	Anders et al.	427/2.3	—

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION	
					YES	NO

10/035,52d

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OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
CB	C.-M. Chan et al., "Polymer surface modification by plasmas and photons", <i>Surface Science Reports</i> , 24 (1996) 1-54.
CB	R.R. Rye, "Radiation Hardening of Polytetrafluoroethylene Against Chemical Etching", <i>Journal of Polymer Science: Part B: Polymer Physics</i> , Vol. 26, 2133-2144 (1988)
CB	<i>Polymer Surfaces From Physics to Technology</i> , John Wiley & Sons, (1994) pp.223-273.
CB	M.P. Stevens, <i>Polymer Chemistry an Introduction</i> , (1975) pp.196-203.
CB	Shen et al., "A Kinetic Study on MMA Bulk Radical Polymerization", <i>Polymer International</i> , 28, (1992) 75-79.

EXAMINER <u>CL-R</u>	DATE CONSIDERED 8/16/04
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT Form PTO-1449	ATTY. DOCKET NO. 11113/9	TC 1700 SERIAL NO. To be assigned
	APPLICANT(S) WANG et al.	10/036,561
	FILING DATE Herewith	GROUP 1772 To be assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	4,331,697	May 25, 1982	Kudo et al.		
	4,377,010	March 22, 1983	Fydelor et al.		
	4,442,133	April 10, 1984	Greco et al.		
	4,589,964	May 20, 1986	Mayhan et al.		
	4,743,258	May 10, 1988	Ikada et al.		
	4,978,481	December 18, 1990	Janssen et al.		
	5,002,582	March 26, 1991	Guire et al.		
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	5,741,551	April 21, 1998	Guire et al.		
	5,782,908	July 21, 1998	Cahalan et al.		
	6,013,855	January 11, 2000	McPherson et al.		
	6,096,369	August 1, 2000	Anders et al.		

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION	
					YES	NO



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TC 1700

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OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
	C.-M. Chan et al., "Polymer surface modification by plasmas and photons", <i>Surface Science Reports</i> , 24 (1996) 1-54.
	R.R. Rye, "Radiation Hardening of Polytetrafluoroethylene Against Chemical Etching", <i>Journal of Polymer Science: Part B: Polymer Physics</i> , Vol. 26, 2133-2144 (1988)
	<i>Polymer Surfaces From Physics to Technology</i> , John Wiley & Sons, (1994) pp.223-273.
	M.P. Stevens, <i>Polymer Chemistry an Introduction</i> , (1975) pp.196-203.
	Shen et al., "A Kinetic Study on MMA Bulk Radical Polymerization", <i>Polymer International</i> , 28, (1992) 75-79.

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